

Notice of References Cited	Application/Control No. 10/551,710	Applicant(s)/Patent Under Reexamination CONDE ET AL.	
	Examiner Bruck Kifle, Ph.D.	Art Unit 1624	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Miller et al. (J. Med. Chem. 2000, 43, 22-26).
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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